		Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited		09/784,158	WEGERICH ET AL.
		Examiner	Art Unit	Page 1 of 1
		Russell L. Guill	2123	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,272,449	08-2001	Passera, Anthony	703/2
	B	US-6,278,962	08-2001	Klimasauskas et al.	703/13
	C	US-5,764,509	06-1998	Gross et al.	700/29
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Black, Christopher L.; Uhrig, Robert E.; Hines, J. Wesley; "System Modeling and Instrument Calibration Verification with a Nonlinear State Estimation Technique", Maintenance and Reliability Conference Proceedings, May 12 - 14, 1998
	V	Freund, Rudolf J.; Wilson, William J.; "Statistical Methods", 1993, Academic Press
	W	Rubinstein, Reuven Y.; "Simulation and the Monte Carlo Method", 1981, John Wiley & Sons
	X	Wong, Man To; Geva, S.; Orlowski, M.; "Pattern recognition from neural network with functional dependency preprocessing", 1997, Proceedings of IEEE Speech and Technologies for Computing and Telecommunications

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.